

A HARPSS Polysilicon Vibrating Ring Gyroscope

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Abstract—This paper presents the design, fabrication, and testing of an 80- μm -thick, 1.1 mm in diameter high aspect-ratio (20:1) polysilicon ring gyroscope (PRG). The vibrating ring gyroscope was fabricated through the high aspect-ratio combined poly and single-crystal silicon MEMS technology (HARPSS). This all-silicon single-wafer technology is capable of producing electrically isolated vertical electrodes as tall as the main body structure (50 to 100's (μm) tall) with various size air-gaps ranging from submicron to tens of microns. A detailed analysis has been performed to determine the overall sensitivity of the vibrating ring gyroscope and identify its scaling limits. An open-loop sensitivity of 200 $\mu\text{V}/\text{deg/s}$ in a dynamic range of ± 250 deg/s was measured under low vacuum level for a prototype device tested in hybrid format. The resolution for a PRG with a quality factor (Q) of 1200, drive amplitude of 0.15 μm , and sense node parasitic capacitances of 2 pF was measured to be less than 1 deg/s in 1 Hz bandwidth, limited by the noise from the circuitry. Elimination of the parasitic capacitances and improvement in the quality factor of the ring structure are expected to reduce the resolution to 0.01 deg/s/(Hz)^{0.5}. [627]

Index Terms—Deep trench etching, gyroscope, high aspect-ratio, microelectromechanical systems (MEMS), silicon micromachining, vibratory gyroscope, yaw rate sensor.

I. INTRODUCTION

SILICON-MICROMACHINED vibratory gyroscopes have received a lot of attention during the past few years as many applications exist for these miniature devices. They can be used either as a low-cost companion with micromachined accelerometers to provide heading information for inertial navigation purposes or stand alone and be used in other applications where rotation rate needs to be measured; examples of these being automotive applications such as traction control systems, ride stabilization and roll-over detection; some consumer electronic applications such as stabilization of pictures in digital video camera and inertial mouse in computers; robotics applications; and, a wide range of military applications such as guidance of missiles and platform stabilization. Much of the effort in developing micromachined gyroscopes has concentrated on “rate grade” devices for automotive applications, which require a rotation rate resolution and bias stability of about 0.5 deg/s. However, several applications require improved

performance, including inertial navigation and guidance of missiles. Achieving “tactical and inertial grade” performance levels [1], i.e., resolution and bias stability better than 1–10 deg/h and high scale factor accuracy in a bandwidth of 10–100 Hz, has proven to be a tough challenge and new technologies and approaches are being developed to allow micromachined gyroscopes achieve this level of performance. The clover-leaf gyroscope of the Jet Propulsion Laboratory (JPL) is an example of a precision bulk micromachined MEMS vibratory gyroscope with a reported resolution and bias stability of ~ 10 deg/h [2]. Other examples of high performance silicon-micromachined vibratory gyroscopes are the silicon-on-glass tuning-fork gyroscope reported by the Charles Stark Draper Laboratory [3], the polysilicon surface micromachined gyroscope reported by the Institute of Micromachining and Information Technology (IMIT) in Germany [4], and Samsung’s silicon-on-insulator (SOI) lateral gyroscope [5]. A comprehensive review of micromachined gyroscopes is given by the authors in [1].

This paper reports the design, fabrication, and testing of a high aspect-ratio (20:1) 80 μm tall vibrating polysilicon ring gyroscope (PRG) [6], [7] fabricated using the high aspect-ratio combined poly and single-crystal silicon (HARPSS) MEMS technology [8]. HARPSS is a mixed-mode microfabrication technology that combines the best features of bulk micromachining with surface micromachining to produce hundreds of microns thick silicon structures with various size airgaps ranging from submicron to tens of microns. A detailed analysis has been performed to determine the overall sensitivity and noise floor of the vibrating ring gyroscope and identify its scaling limits. Several aspects of this analysis apply to other gyroscope sensing structures and are discussed in detail. It is shown through this analysis that the HARPSS technology provides features that are required to achieve high performance. An 80- μm tall, 1.1 mm in diameter vibratory PRG has been successfully fabricated using this technology and test results obtained from the open-loop operation of a prototype gyroscope under vacuum are presented.

II. THE VIBRATING RING GYROSCOPE

The vibrating ring gyroscope, shown in Fig. 1, consists of a ring, eight semicircular support springs, and drive, sense and control electrodes [9]. Symmetry considerations require at least eight springs to result in a balanced device with two identical elliptically-shaped flexural modes that have equal natural frequencies and are 45° apart from each other [10]. As shown in Fig. 2, the antinodes of the second flexural mode are located at the nodes of the first flexural mode. The ring is electrostatically vibrated into the primary flexural mode with a fixed amplitude. When device is subjected to rotation around its normal

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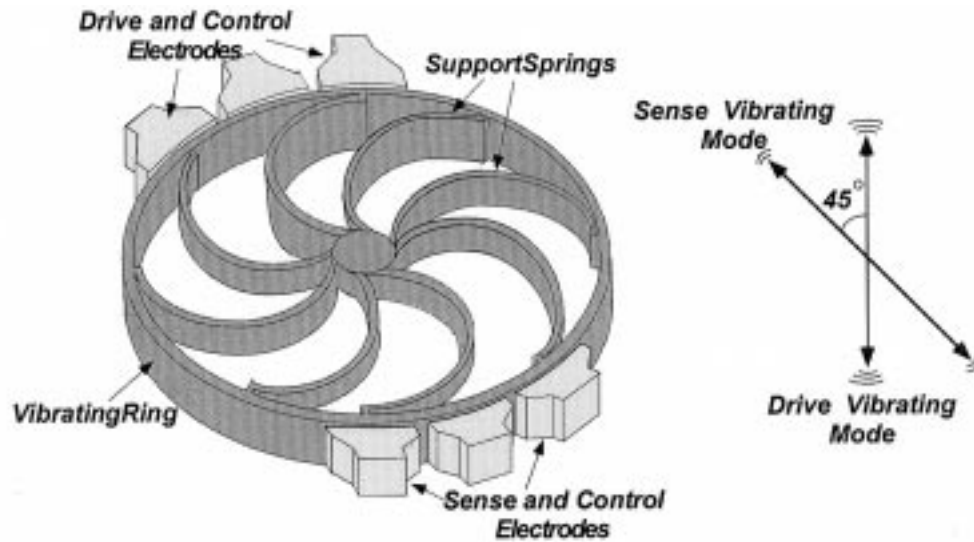


Fig. 1. Structure of a Vibrating Ring Gyroscope.

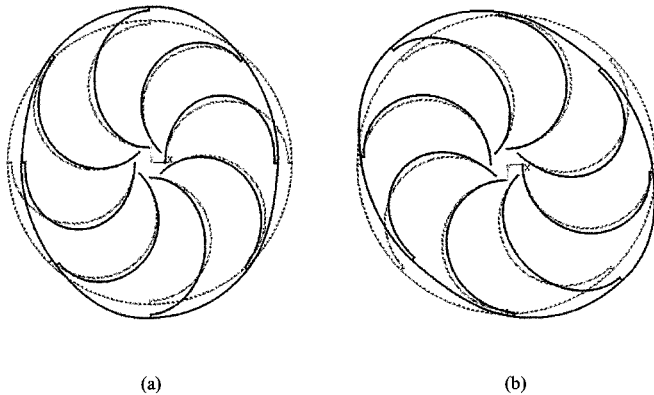


Fig. 2. Flexural modes of vibration used for operation of the vibrating ring gyroscope. (a) The first flexural mode and (b) the second flexural mode, located 45° apart from the first mode with identical frequencies.

axis, Coriolis force causes energy to be transferred from the primary mode to the secondary flexural mode, which is located 45° apart from the primary mode, causing amplitude to build up proportionally in the latter mode; this build-up is capacitively monitored. It has been shown in [10] that in the open-loop mode of operation, the amplitude of the second mode, or the sense mode (q_{sense}), is proportional to the rotation rate and is given by

$$q_{\text{sense}} = 4A_g \cdot \frac{Q}{\omega_0} \cdot q_{\text{drive}} \cdot \Omega_z \quad (1)$$

where

- $A_g \approx 0.37$ angular gain of the ring structure (which depends on the geometry of the sensor and is very stable over temperature and lifetime of the device);
- Q quality factor of the mechanical structure;
- ω_0 angular flexural resonance frequency;
- q_{drive} vibration amplitude of the drive mode;
- Ω_z rotation rate.

The vibrating ring structure has some important features compared to other types of vibratory gyroscopes. First, it has a balanced symmetrical structure that is less sensitive to spurious

vibrations. Only when the ring has mass or stiffness asymmetries can environmental vibrations induce a spurious response. Second, since two identical flexural modes of the structure “with nominally equal resonant frequencies” are used to sense rotation, the sensitivity of the sensor is amplified by the quality factor of the structure, resulting in higher sensitivity. Third, the vibrating ring is less temperature sensitive since the two flexural vibration modes are affected equally by temperature. Finally, electronic tuning of the structure is possible. Any frequency mismatch between the drive and sense resonance modes that occurs during fabrication process (due to mass or stiffness asymmetries) can be electronically compensated by use of the tuning electrodes that are located around the structure.

The first micromachined version of the vibrating ring gyroscope was fabricated by electroforming nickel into a thick polyimide (or photoresist) mold on a silicon substrate in a postcircuit process [9]. The gyroscope demonstrated a resolution of ~ 0.5 deg/s in a 10-Hz bandwidth limited by the readout electronic noise. The sensor was integrated with a low-input capacitance source-follower buffer and the amplifier on a silicon chip. The zero bias drift was smaller than 10 $\%$ /s over the temperature range -40°C to 85°C , and the sensitivity of the device varied by less than 3% over the same temperature range. Scale factor nonlinearity in a ± 100 deg/s rate range was $< 0.2\%$ [11]. However, the nickel electroforming technology used for this device poses several drawbacks to improved device performance, including: 1) a fairly large ring to electrode gap spacing were achievable in the conventional electroplating process, which resulted in a small sense capacitance; although this could be overcome by more sophisticated technologies like LIGA, it is not desirable to use these because of cost considerations; 2) the thermal expansion coefficient of the silicon substrate is different than the sensor element, which was made out of nickel. Therefore as the temperature changes, the ring expands (or shrinks) more than the electrodes, which are attached to the substrate, causing the ring-to-electrode gap spacing to change; this in turn results in an increased temperature sensitivity of offset and scale factor; and 3) worse material properties of nickel, resulting in

lower Q , and higher potential for creep, fatigue and long-term drift.

British Aerospace Systems and Equipment (BASE) has developed a micromachined single crystalline silicon ring gyroscope with a reported rms noise floor of $0.15^\circ/s$ in a 30-Hz bandwidth and an in-run drift of approximately $0.05^\circ/s$ [12]. This device was fabricated through deep dry etching of $100\text{-}\mu\text{m}$ -thick silicon wafer which was then anodically bonded to a glass support wafer. Single crystal silicon ring structure will have the advantage of intrinsic high quality factor required for high performance vibratory gyroscopes. However, the Young's modulus of single crystal silicon varies with crystallographic orientation around the ring structure with a " $\text{Cos } 4\theta$ " dependence. For a uniform circular ring, this anisotropy will cause the sense and drive mode resonance frequencies to be different. This split in the frequency is significant and reduces the sensitivity if not compensated. Modulation of the ring width in a $\text{Cos } 4\theta$ manner can be used to compensate this anisotropy [13].

III. THE HIGH ASPECT-RATIO PRG

To further improve the performance and overcome the shortcomings of the nickel vibrating ring gyroscope, the authors have developed a high aspect-ratio polysilicon vibrating ring gyroscope structure fabricated through the HARPSS MEMS Technology. The single wafer, all-silicon HARPSS process has been described in details in [8]. Using this technology, the vibrating ring and support springs are created by refilling $80\text{ }\mu\text{m}$ deep dry-etched trenches with polysilicon deposited over a sacrificial LPCVD oxide layer. Each sense electrode is made out of low-resistivity single-crystal silicon island that is protected on the sides by deep refilled trenches and is released at the bottom from the substrate by means of an SF_6 dry-release that is carried out entirely in a deep reactive ion etching (DRIE) system. The single-crystal silicon islands are all anchored on top to a supporting polysilicon layer, which is anchored through an isolating nitride layer to the substrate. The polysilicon ring is anchored in the middle to the substrate and is suspended using the support springs over an etch pit that is created through SF_6 dry etching of silicon substrate in a DRIE system. Fig. 3 shows a SEM picture of a $1.7 \times 1.7\text{ mm}^2$ PRG. The ring is 1.1 mm in diameter and the diameter of the support post is $120\text{ }\mu\text{m}$. The width of the ring and support springs is $4\text{ }\mu\text{m}$. Sixteen electrodes are evenly located around the structure; they are approximately $60\text{ }\mu\text{m}$ tall and $150\text{ }\mu\text{m}$ long and are separated from the ring by a $1.4\text{ }\mu\text{m}$ capacitive air-gap. Fig. 4 shows an SEM view of a $60\text{-}\mu\text{m}$ -tall electrode separated from the ring by $1.4\text{ }\mu\text{m}$ capacitive gap in a prototype device.

This technology provides several important features that are required for high-performance MEMS microgyroscopes. First, it allows the polysilicon ring structure and the surrounding electrodes to be made hundreds of microns thick using DRIE technique. Second, since the ring to sense-electrode gap spacing is defined by the thickness of the sacrificial layer, it can be reduced to submicron level; these two factors together will significantly increase the sense capacitance and hence the device output signal. Third, the structural material is polysilicon which has a high quality factor and an orientation independent Young's

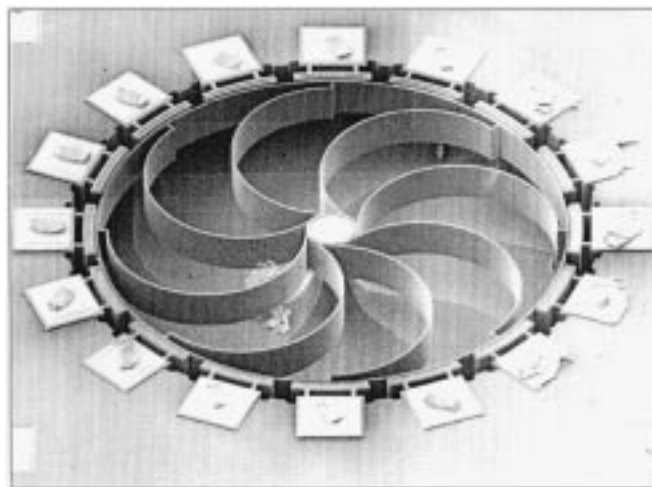


Fig. 3. SEM view of a prototype $1.7\text{ mm} \times 1.7\text{ mm}$ HARPSS PRG. The ring is $80\text{-}\mu\text{m}$ thick and 1.1 mm in diameter; the diameter of the support post is $120\text{ }\mu\text{m}$.

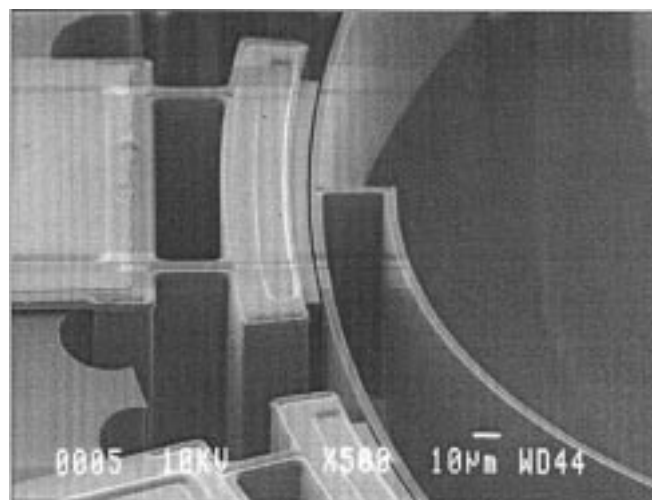


Fig. 4. Close-up of a $60\text{-}\mu\text{m}$ -tall electrode separated from the ring by $1.4\text{ }\mu\text{m}$ capacitive gap in a HARPSS PRG.

modulus. Fourth, the all-silicon feature of this technology improves long-term stability and temperature sensitivity. These features play an instrumental role in allowing the performance of the vibrating ring gyroscopes to be improved by orders of magnitude as indicated in the following analysis.

IV. SENSITIVITY AND NOISE ANALYSIS

Vibration of the ring gyroscope causes the ring-to-electrode gap to vary as a function of time and position along the electrode. In order to vibrate the ring in its first flexural mode that has two nodal diameters, a sinusoidal electrostatic drive force is applied through the surrounding electrode located at a reference zero degree point. The ideal vibrating ring structure has two identical flexural modes that have equal resonant frequencies. Each sense electrode incorporates a low-input capacitance unity-gain buffer amplifier (source follower) to sense the small capacitance changes between the ring and the pickoff electrode due to ring vibration. Fig. 5 shows the detection scheme used

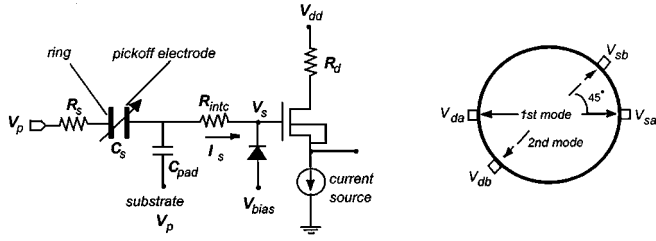


Fig. 5. Detection scheme used to sense ring vibration.

to sense ring vibrations. The ring is set at a polarization voltage V_p to provide the bias for capacitive detection and to avoid frequency doubling of the drive force. The input bias voltage of the unity-gain buffer amplifier, V_{bias} , is set through an isolated minimum geometry diode [10]. Two pickoff electrodes, located at 0° and 45° are used to sense the ring vibration while two electrodes located directly across, at 180° and 225° , are used to drive the ring (Fig. 5). Each drive electrode is driven by an ac drive voltage (v_{da} and v_{db}) which combine with the polarization voltage V_p . The ac voltages developed at the sense electrodes, v_{sa} and v_{sb} , are generated by the vibration of the ring.

For each sense electrode, $V_s = V_{\text{bias}} + v_s$, where V_{bias} is the bias voltage applied through the input diode and v_s is the ac sense voltage. I_s , the current flowing through the combination of the sense electrode capacitance (C_s) and the capacitance associated with the output pad to the substrate (C_{pad}) (substrate is assumed to be at the polarization voltage V_p) is injected into the gate of the source follower and can be expressed by

$$I_s = \frac{d}{dt}(Q) = \frac{d}{dt}[(C_d + \delta c_d + C_{\text{pad}})(V_p - V_{\text{bias}} - v_s)] \quad (2)$$

where C_d and δc_d are the average and the time varying components of the ring to sense electrode capacitance (C_s), respectively. R_s is the series resistance associated with the path connecting the point where V_p is applied to the ring itself; due to the high doping level of polysilicon, this resistance is negligible compared to the impedance of the sense capacitance, and for simplifying purposes it is assumed to be zero. If the input capacitance of the buffer amplifier to ground is C_{imp} , one can find an expression for v_s as [14]

$$v_s \approx \frac{\delta c_d}{(C_d + C_{\text{pad}} + C_{\text{imp}})}(V_p - V_{\text{bias}}), \quad (3)$$

Expression (3) states that in order to get higher sensitivity, the amount of change in ring to sense electrode capacitance due to the ring vibration should be maximized while the total sum of rest and parasitic capacitances ($C_d + C_{\text{pad}} + C_{\text{imp}}$) should be minimized. So, a buffer amplifier with very small input capacitance must be used and the output pad capacitance to the substrate should be minimized. The electrode capacitance can be expressed by (to a good approximation)

$$C_{sn} = \int_{\theta_n - (\Delta\theta_n/2)}^{\theta_n + (\Delta\theta_n/2)} \frac{\epsilon \cdot h}{(d_0 + \Delta d)} \cdot r \cdot d\theta \quad (4)$$

where

- d_0 equilibrium gap spacing;
- Δd change in the gap due to vibration;
- h height of the structure;
- r radius of the ring;
- $\Delta\theta$ angle faced by each electrode.

One can simplify (4) by using the Taylor series expansion

$$\left(1 + \frac{\Delta d}{d_0}\right)^{-1} \cong 1 - \frac{\Delta d}{d_0} + \left(\frac{\Delta d}{d_0}\right)^2 - \dots, \text{ for } \frac{\Delta d}{d_0} \ll 1$$

to obtain

$$C_{sn} = \frac{\epsilon \cdot h \cdot r}{d_0} \cdot \left\{ \int_{\theta_n - (\Delta\theta_n/2)}^{\theta_n + (\Delta\theta_n/2)} \left(d\theta - \frac{\Delta d}{d_0} \cdot d\theta + \left(\frac{\Delta d}{d_0}\right)^2 \cdot d\theta \right) \right\}. \quad (5)$$

As mentioned earlier, the ring vibrates in elliptically shaped mode patterns that have two node lines. In polar coordinates, $\Delta d = -(q_1\Phi_{r1} + q_2\Phi_{r2})$, where the radial mode shape functions Φ_{r1} and Φ_{r2} , for the ring portion of the sensor structure alone, are given by the expressions [10]

$$\begin{aligned} \Phi_{r1} &= \cos(2\theta - 2\theta_0) \\ \Phi_{r2} &= \sin(2\theta - 2\theta_0) \end{aligned} \quad (6)$$

θ_0 is the location of the anti-node of the normal mode. In order to simplify the math, we can assume that θ_0 is equal to zero; also for the sense electrode located at the 45° position, Φ_{r2} would be much larger than Φ_{r1} , allowing us to assume that $\Delta d \cong -q_2\Phi_{r2}$ (q_2 is the amplitude of the secondary vibration mode of the ring). Therefore, for the sense electrode located at 45° , we can further simplify (5) by neglecting the higher order terms to $C_{sn} \cong C_d + \delta c_d$, where

$$C_d = \frac{\epsilon \cdot h \cdot r}{d_0} \cdot \Delta\theta \quad (7)$$

$$\delta c_d = \left[\frac{\epsilon \cdot h \cdot r}{d_0^2} \cdot \sin(\Delta\theta) \right] \cdot q_2. \quad (8)$$

If we combine (8) with (3), the following expression for the amplitude of the sense voltage developed at the 45° pickoff can be obtained:

$$v_s \cong \frac{(V_p - V_{\text{bias}})}{(C_d + C_{\text{pad}} + C_{\text{imp}})} \cdot \frac{\epsilon \cdot h \cdot r \cdot \sin(\Delta\theta)}{d_0^2} \cdot q_2. \quad (9)$$

In this equation, q_2 is the vibration amplitude of the sense mode (q_{sense}) and is determined by the vibration amplitude of the drive mode, q_{drive} , through the rotation sensitivity of the ring structure given by (1). By combining (9) with (1), the following general expression for open loop sensitivity of the sensor is resulted:

$$v_s \cong \frac{4A_g(V_p - V_{\text{bias}})}{(C_d + C_{\text{pad}} + C_{\text{imp}})} \cdot \frac{\epsilon \cdot h \cdot r \cdot \sin(\Delta\theta)}{d_0^2} \cdot \frac{\Omega_z}{\omega_0} \cdot Q \cdot q_{\text{drive}}. \quad (10)$$

The minimum detectable rotation rate for the vibrating shell structure, $\Omega_{z(\min)}$, is directly proportional to the minimum detectable sense voltage, $v_{s(\min)}$, which is determined by the input referred noise of the interface circuit and the noise voltage developed at the sense node due to Brownian motion of the structure. The Brownian noise of the structure will be discussed in the next section and is assumed to be zero in the electronic noise floor calculations. If we assume that the noise from the output buffer, V_n , has a white spectrum near the flexing frequency of the ring and the bandwidth of the detection circuit is BW , then the minimum detectable rotation rate limited by electronic noise only (electronic noise floor) can be expressed by (11) shown at the bottom of the page.

Equation (11) suggests that in order to reduce the electronic noise floor of the ring gyroscope, one has to

- reduce the sense electrode gap spacing (d_0^2);
- increase the height (h) and radius (r) of the structure as well as angle faced by each electrode ($\Delta\theta$);
- increase the quality factor of the structure (Q);
- reduce the natural resonance frequency of the structure (ω_0).
- minimize the input referred equivalent noise of the detection circuit (V_n);
- minimize the total amount of the rest capacitances attached to the output node ($C_d + C_{\text{pad}} + C_{\text{inp}}$);
- increase the drive amplitude (q_{drive});
- increase the polarization voltage (V_p).

The vibration amplitude of the ring gyroscope, q_{drive} , should be set as large as possible to increase the sensitivity (stronger Coriolis forces will be resulted by increasing the amplitude of vibration in the drive mode q_{drive}), but it must be kept typically below 10% of the equilibrium gap spacing of the drive electrode to avoid the nonlinear effects of the electrostatic force. The polarization voltage cannot be increased indefinitely as V_p has to be less than the pull-in voltage of the structure. The resonance frequency of the structure should be lowered for improved sensitivity; however, it must be kept above the environmental noise frequencies to make the sensor immune against spurious vibrations (> 2 kHz). However, a decrease in the resonance frequency of the structure will increase the Brownian noise floor of the device.

A. Brownian Noise Floor

Brownian motion of the proof mass caused by molecular collisions from the surrounding environment represents the fundamental limiting noise component of a sensor structure. By Nyquist's Relation, the spectral density of the fluctuating force related to any mechanical resistance R is given by [15]

$$F_n = \sqrt{4k_B T R} \quad \text{N}/\sqrt{\text{Hz}} \quad (12)$$

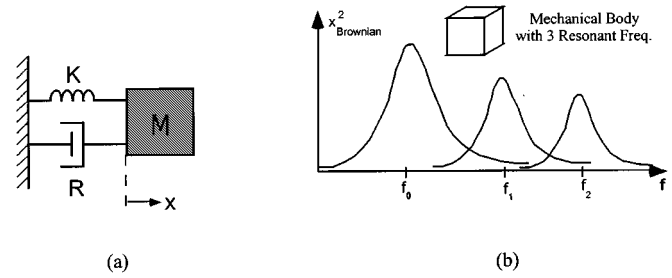


Fig. 6. (a) Second order mass-spring system. (b) Spectral density of displacement of a mechanical element with three resonant frequencies due to Brownian motion.

where k_B is Boltzmann's constant (1.38×10^{-23} J/K) and T is the absolute temperature. For a second order mass-spring-damper system shown in Fig. 6(a), the Brownian noise displacement corresponding to the fluctuating force related to a mechanical resistance R becomes

$$|x_{\text{Brownian}}| = \sqrt{4k_B T R} \cdot G(f) \quad \text{m}/\sqrt{\text{Hz}} \quad (13)$$

where $G(f)$ is the displacement to force transfer function of the second-order mass-spring-damper system

$$G(f) = \frac{K^{-1}}{\sqrt{\left[1 - \left(\frac{f}{f_0}\right)^2\right]^2 + \left(\frac{f}{Q f_0}\right)^2}} \quad (14)$$

K is the generalized stiffness of the structure, $R = K/(Q\omega_0)$, $Q = \sqrt{KM}/R = \omega_0 M/R$, and $\omega_0 = \sqrt{K/M}$. M is the generalized mass of the vibration mode, ω_0 is the resonance frequency of the vibration mode, and Q is the quality factor. It should be noted that (12) can be derived directly from the equipartition theorem which states that any energy storage mode of a system in thermal equilibrium has an average energy of $\frac{1}{2}k_B T$ [15]. The mean square Brownian noise displacement of a mass-spring-damper system for a given resonance mode is expressed by

$$\frac{1}{2}K\langle x^2 \rangle = \frac{1}{2}k_B T \quad (15)$$

where $\langle x^2 \rangle$ is the integral sum of $|x|^2$ over all frequencies. Using (15) and considering the fact that for a mass-spring-damper system $|x| = F_n \cdot G(f)$ in which F_n is the white noise force, integration of $|x|^2$ over range of all frequencies ($0, \infty$) will result in (12) [16].

The displacement noise x_{Brownian} peaks at the resonance frequency and becomes Q times larger than below resonance values, as shown in Fig. 6(b)

$$\text{for } \omega = \omega_0 \Rightarrow |x_{\text{Brownian}}| = \sqrt{\frac{4k_B T Q}{M\omega_0^3}} \quad (16)$$

$$\Omega_{z(\text{electronic})} \cong \frac{(C_d + C_{\text{pad}} + C_{\text{inp}})}{4A_g(V_p - V_{\text{bias}})} \cdot \frac{d_0^2}{\varepsilon \cdot h \cdot r \cdot \sin(\Delta\theta)} \cdot \frac{\omega_0}{Q} \cdot \frac{1}{q_{\text{drive}}} V_n \cdot \sqrt{BW} \quad (11)$$

For a ring gyroscope with matched drive and sense resonance modes, the output displacement response of the sense mode to an input rotation rate of Ω_z due to the Coriolis force of $f_{\text{Coriolis}} = 4A_g\Omega_z M\omega_0 q_{\text{drive}}$ is expressed by

$$x_s = 4A_g\Omega_z M\omega_0 q_{\text{drive}} \cdot G(f). \quad (17)$$

Therefore, the signal-to-thermal noise ratio at any frequency in a bandwidth of BW is then expressed by

$$\left| \frac{x_s}{x_{\text{Brownian}}} \right| = \frac{4A_g\Omega_z M\omega_0 q_{\text{drive}}}{\sqrt{4k_B T} \frac{\omega_0 M}{Q} \cdot \sqrt{BW}}. \quad (18)$$

By $|x_s/x_{\text{Brownian}}| = 1$, we can find an expression for the Brownian noise floor of the ring gyroscope in a bandwidth of BW

$$\Omega_{z(\text{Brownian})} = \frac{1}{4A_g q_{\text{drive}}} \cdot \sqrt{\frac{4k_B T}{\omega_0 M Q}} \cdot \sqrt{BW} \quad \text{rad/s.} \quad (19)$$

Therefore, in order to reduce the Brownian noise floor of a ring gyroscope:

- the generalized mass of the structure (M) and its resonance frequency (ω) should be increased;
- the amplitude of the drive mode should be increased (q_{drive});
- the sensor structure should have a high quality factor (Q).

Since the Brownian and the electronic noise are uncorrelated, the overall noise floor of the gyroscope is then given by

$$\Omega_{z(\text{min})} = \sqrt{\Omega_{z(\text{electronic})}^2 + \Omega_{z(\text{Brownian})}^2}. \quad (20)$$

B. Resonance Frequency of the Ring Gyroscope

The natural frequency for the radial-circumferential flexural modes of a cylindrical shell with a radius r and a shell thickness t is given by [17]

$$f_i = \frac{1}{2\pi} \cdot \frac{1}{\sqrt{12}} \cdot \frac{t}{r^2} \cdot \frac{i(i^2 - 1)}{\sqrt{(i^2 + 1)}} \cdot \sqrt{\frac{E}{\rho}}, \quad i = 2, 3, 4, \dots \quad (21)$$

where E is the Young's modulus and ρ is the density of the shell material. Natural frequencies of the flexural modes are independent of the height of the shell structure. Using (21), it is possible to approximately calculate the flexural resonance frequency of the ring gyroscope. Since $f_i = (1/2\pi)\sqrt{k_1/M}$ and $M(\text{mass}) \propto r$, we can see that $k_i \propto (1/r^3)$. In case of a ring gyroscope in which the radius of each supporting spring is approximately equal to 0.43 of the radius of the ring itself, flexural stiffness of each spring can be calculated to be 6.4 times larger than the stiffness of the ring shell without any springs attached to it (note that two springs in parallel make a full ring; therefore, the stiffness of each semicircular spring is half of the stiffness of a circular ring). Therefore, the overall stiffness for the flex-

TABLE I
SPECIFICATIONS AND CALCULATED PERFORMANCE OF THE HARPSS
POLYSILICON VIBRATING RING GYROSCOPE

| Design Parameter | Target Value |
|--|--|
| Material Quality Factor | 20,000 |
| Ring Diameter | 1.1 mm |
| Ring and Springs Width | 4 μm |
| Height of the Ring Structure | 80 μm |
| Support Post Diameter | 120 μm |
| Support Spring Diameter | 470 μm |
| Sense Electrode Gap Spacing | 1.4 μm |
| Height of Each Electrode | 60 μm |
| Resonant Frequency | 29 kHz |
| Interface Circuit Input Noise (V_n) | 1 $\mu\text{V}/(\text{Hz})^{0.5}$ |
| Parasitic Capacitance ($C_{\text{device}} + C_{\text{pad}}$) | 500 fF |
| Polarization Voltage (V_p) | 7V |
| Drive amplitude | 0.15 μm |
| Brownian Noise Floor | 0.01 deg/sec/(Hz) ^{0.5} |
| Electronic Noise Floor | 8×10^{-3} deg/sec/(Hz) ^{0.5} |
| Min. Detectable Signal (10Hz BW) | 0.04 deg/sec |

ural mode of the ring gyroscope with eight springs will be 7.4 times the stiffness of a ring without springs. If we consider the effective mass of the spring to be one third of its actual mass, then the natural frequency for the first flexural mode of the ring can be estimated by ($i = 2$ in (21))

$$f_{\text{ring gyro}} \cong \frac{\sqrt{3}}{2\pi} \cdot \frac{t}{r^2} \cdot \sqrt{\frac{E}{\rho}}. \quad (22)$$

If we assume that the Young's modulus of polysilicon is approximately equal to $E = 150 \text{ GPa} = 1.5 \times 10^{12} \text{ dynes/cm}^2$ and its density is equal to $\rho_{\text{Si}} = 2.328 \text{ g/cm}^3$, for a ring gyroscope with a ring diameter of 1.1 mm and a ring width (t) of 4 μm , the resonance frequency of the first flexural mode can be calculated to be equal to $f_{\text{ring gyro}} \cong 29 \text{ kHz}$. Care must be taken in using (22) since it has been derived based on the specific dimensions of the polysilicon ring gyroscope described in this paper. Table I summarizes the design parameters and the expected resolution for a 1.1 mm in diameter, 80 μm tall HARPSS polysilicon ring gyroscope.

V. TEST RESULTS

Prototypes of 80 μm thick HARPSS polysilicon ring gyroscopes were tested under vacuum for open loop operation. The sensor chip was connected in hybrid format to an NMOS source-follower buffer chip, both mounted on a 24-pin ceramic DIP package as shown in Fig. 7, to measure ring vibrations. The low-impedance output signal of this buffer chip was then amplified off-chip by a factor of 100 using discrete amplifiers on a printed circuit board (PCB). This PCB was installed on the rate table, inside the vacuum chamber and its communication with the drive and control circuitry located outside the chamber was made through a set of slip rings. Drive and control circuitry needed for tuning and open loop operation of the ring gyroscope were implemented off chip using discrete components. Part of the electronics drives the first mode of the structure into resonance and keeps the amplitude of vibration constant. This is

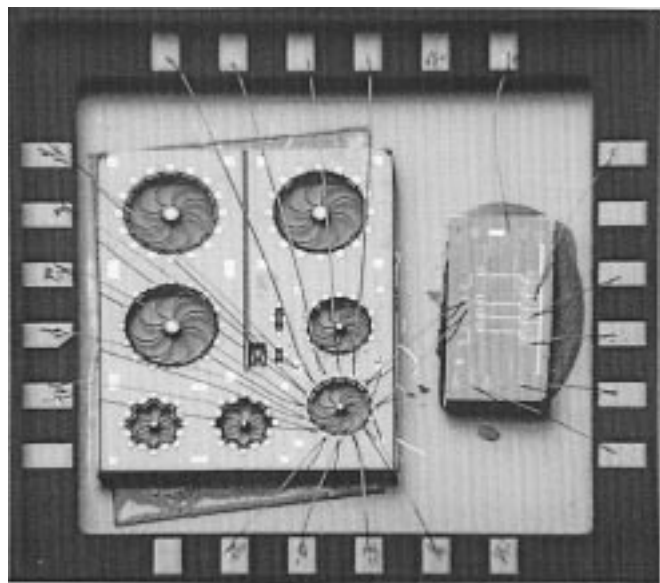


Fig. 7. Hybrid attachment of the ring gyroscope and the unity-gain buffer IC chip in a 24-pin ceramic DIP package.

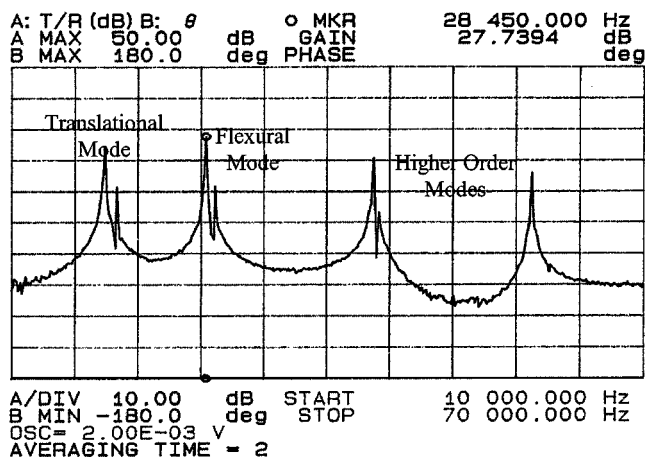


Fig. 8. Frequency response of a prototype HARPSS polysilicon ring gyroscope, showing several vibration modes of the structure.

done by using a phase locked loop (PLL), which continuously forces the frequency of a VCO to track the resonance frequency of the structure. Control electronics will then develop the proper control voltage (v_{da}) by use of a synchronous demodulator to keep the amplitude of vibration constant.

Fig. 8 shows the measured frequency response of an 80 μm thick, 4 μm wide, 1.1 mm in diameter HARPSS PRG, showing various vibration modes of the structure. In this figure, some peaks are in pair. Each pair represents a degenerate mode, such as translational and flexural modes, and frequencies of the two degenerate modes are slightly different due to imperfection or deformation of the ring structure (frequencies are equal in an ideal uniform ring). Electronic balancing will pull the two frequencies together and make them equal through the action of electrostatic springs. Vibration modes of the polysilicon ring gyroscope were also obtained through finite element method (FEM) simulations in ANSYS. Table II summarizes the results obtained from the FEM normal mode analysis of the sensor structure. Simulation results are in good agreement with the

TABLE II
ANSYS SIMULATION RESULTS (shell63) FOR NORMAL MODE ANALYSIS OF A PRG WITH FOLLOWING DIMENSIONS: 1.1 mm IN DIAMETER; 80 μm TALL; 4 μm WIDE; 120 μm IN DIAMETER SUPPORT POST

| Vibration Mode | Frequency (kHz) |
|--|-----------------|
| Torsional | 10.95 |
| In-plane translational "two degenerate modes" | 20.18 |
| Flexural (2 node lines) "two degenerate modes" | 29.28 |
| Higher order flexural (3 node lines) "two degenerate modes" | 43.08 |
| Higher order flexural (4 node lines) | 55.53 |

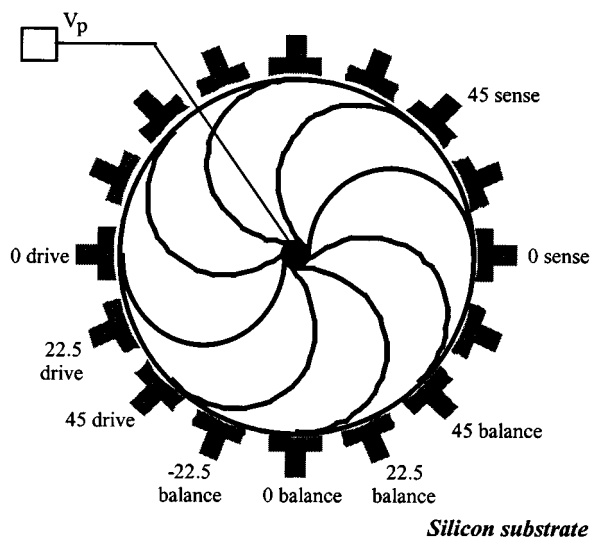


Fig. 9. Electrode representation for the ring gyroscope.

test results. The torsional and out-of-plane modes cannot be excited with current electrode configuration. ANSYS calculated a frequency of 20.18 kHz for the in-plane translational modes of the structure and 29.28 kHz for the first flexural mode. The frequency of the first flexural mode of a prototype device is measured to be 28.3 kHz (with 7 V bias applied to the ring) which agrees well with the calculated value of 29 kHz as well as ANSYS simulation results.

It should be noted that bent-beam strain sensors were also fabricated using the HARPSS process to measure the residual stress in 80 μm thick 4 μm wide trench-refilled polysilicon beams. As reported in reference [8], the in-plane stress for thick polysilicon trench-refilled beams was measured to be virtually zero. This was expected for the trench-refill process in which the residual stress of counterfacing polysilicon layers on the trench sidewalls cancel out each other as the trench is refilled. The good agreement of the measured resonance frequencies with ANSYS simulation results is also another indication that the residual stress in trench-refilled polysilicon beams is negligible.

A. Electronic Tuning

Electronic tuning is an attractive feature of the vibrating ring gyroscope. Any frequency mismatch between the sense

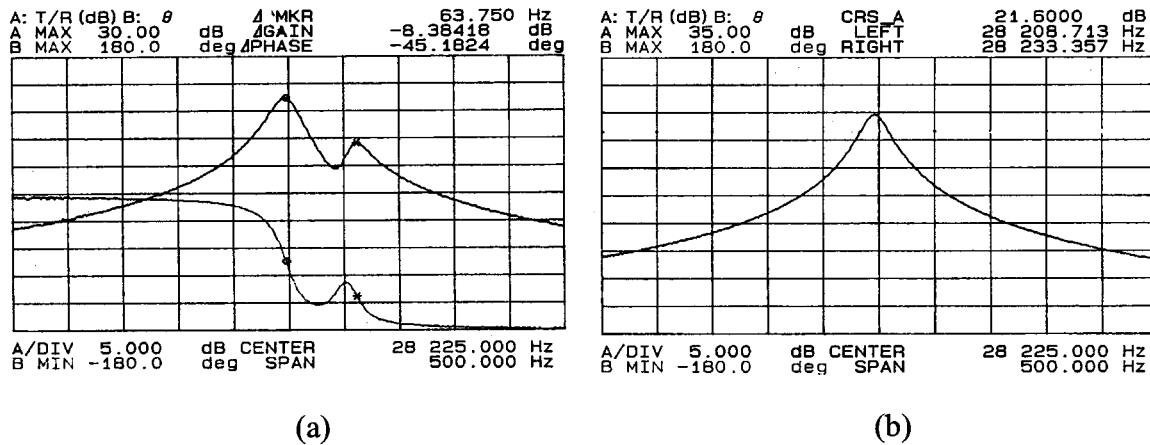


Fig. 10. Electronic balancing of the ring gyroscope. (a) *Before balancing*: Two flexural resonant peaks of a prototype ring gyroscope have different frequencies ($\Delta f = 63$ Hz for $f_0 = 28$ kHz). (b) *After balancing*: Two peaks merge together and the frequencies become equal.

and drive modes that occur during the fabrication process can be electronically compensated using the tuning electrodes around the structure. By matching the drive and sense mode frequencies, sensitivity is amplified by the quality factor of the structure. The tuning procedure for the ring gyroscope has been explained in details in reference [10] and is accomplished by applying dc voltages to two pairs of electrodes as shown in Fig. 9: one pair located at 22.5° and -22.5° , and the other pair located at 0° and 45° angles. The rest of the surrounding electrodes (except the 0° sense and drive and 45° sense electrodes) were grounded. Fig. 10(a) shows the two flexural resonance peaks of a prototype device before the electronic tuning, showing a frequency split of 63 Hz. The frequencies of the two modes of a device can be apart by even a few hundred Hertz due to imperfection in the fabrication process and/or device structure as well as electrostatic stiffening effect of bias voltages applied to the surrounding electrodes. The balancing voltages required to null the 63 Hz of frequency split between the modes of this prototype single ring gyroscope were very small: $V_{\pm 22.5} = \pm 0.9$ V and $V_{0,45} = 0$ V. After balancing, the two peaks merge together and the sense and drive mode frequencies become equal, as shown in Fig. 10(b). It is noteworthy that the balancing voltages needed to null 40 Hz of frequency split between the two modes of a prototype 20 μm tall nickel gyroscope with a 6 μm capacitive gap and a flexural frequency of $f_0 = 33$ kHz was $V_{\pm 22.5} = \pm 15.5$ V [10]. Small capacitive gaps (1.4 μm) and tall electrodes have indeed shifted the tuning voltages down to CMOS acceptable levels, increasing the tuning capability. We have also been able to balance ring structures with up to 1 kHz of frequency split ($f_0 = 28$ kHz) by applying less than 6 Volts tuning voltages to the balancing electrodes [14].

The quality factor (Q) for the first flexural mode of this prototype device was measured to be 2000 after balancing. This is smaller than anticipated due to excessive anchor and bulk losses. Fig. 11 shows a typical anchor problem encountered in early designs of the poly ring gyro. Excessive undercut of the silicon substrate at the post causes the interface oxide layer between the substrate and structural poly to be exposed during the HF release and get etched away, which in turn will result in a soft anchor that dissipates energy. Solid posts significantly reduce dissipa-

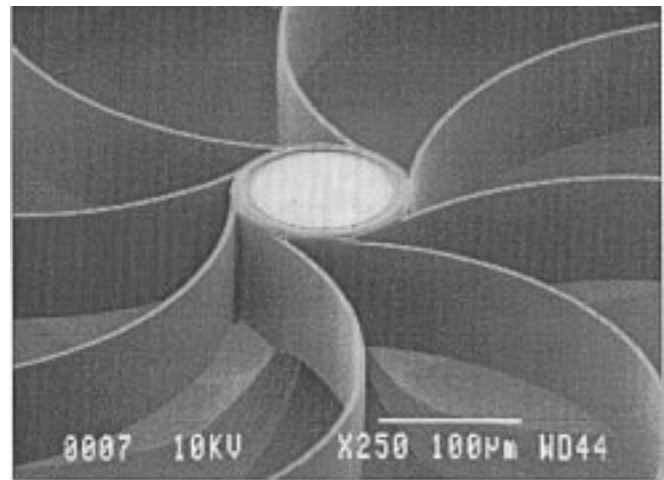


Fig. 11. SEM view of the anchor of a poly ring gyroscope. Excessive undercut of the silicon substrate at the post can result in a soft anchor point and dissipation of energy.

tion of energy through anchor losses. The highest Q measured for the first flexural mode of the polysilicon ring gyroscope with modified solid postdesign has been 6000 under 1 mtorr vacuum [14]. Another possible source of dissipation of energy in trench-refilled polysilicon beams are voids and keyholes that can be generated during the polysilicon refill process, shown in Fig. 12. In order to avoid this problem, trenches with completely vertical (or slightly slanted inward) sidewall profile are needed and enough polysilicon needs to be deposited to completely refill trenches at the wide intersection points. Modified devices with solid post and voidless polysilicon beams are expected to have higher Q in the range of 10 000–20 000 and hence higher sensitivity. 80 μm tall, 300 μm long clamped-clamped beam micromechanical resonators fabricated in this technology have shown quality factors as high as 85 000 in 1 mTorr vacuum [8].

B. Open-Loop Testing

The block diagram of the drive and control circuitry needed for open loop operation of the polysilicon ring gyroscope is shown in Fig. 13. The circuitry was mounted on a bread-board

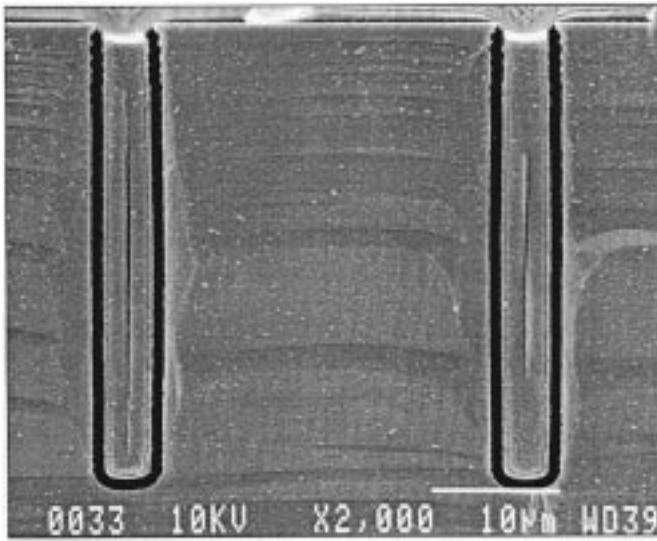


Fig. 12. Voids and keyholes generated during the polysilicon refill process can be potentially a source of dissipation of energy.

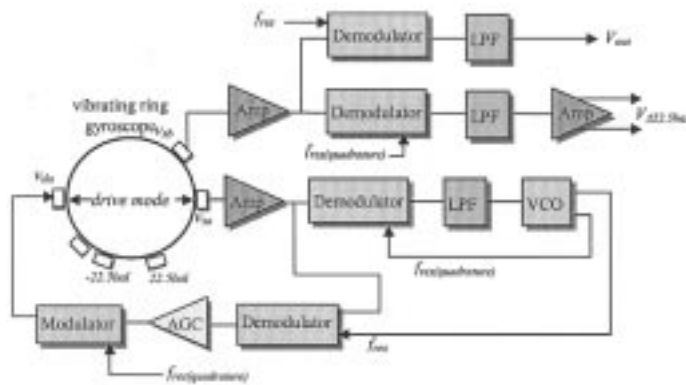


Fig. 13. Block diagram of the drive, readout and control circuitry for open loop operation of the polysilicon ring gyroscope.

outside of the vacuum chamber and consists of three main loops: The main control loop that is based on a phase locked loop oscillator circuit that locks into the resonance frequency of the gyroscope. This PLL circuit is based on the phase relationship between the drive force and the output displacement. At resonance, the vibrational displacement of the structure lags behind the applied drive force by 90° . This phase difference is measured using a balanced demodulator. The second loop, which is called the amplitude control loop, accurately control the amplitude of the reference vibration to minimize gain errors in the sensor output. So, the main and amplitude control loops operate together to resonate the ring structure into its first flexural mode and keep the vibration amplitude constant. Fig. 14 shows the waveforms from a prototype polysilicon ring gyroscope. The lower trace is the square wave drive signal applied to the 0° drive electrode and the top trace is the output signal recorded from the 0° sense electrode. The two waveforms have the anticipated 90° phase difference. The typical amplitude of the drive signal is around 5–8 mV peak. Larger drive levels will cause distortion in the output signal (maximum displacement must be kept less than 10% of the air-gap for linear operation in electrostatic parallel plate actuators).

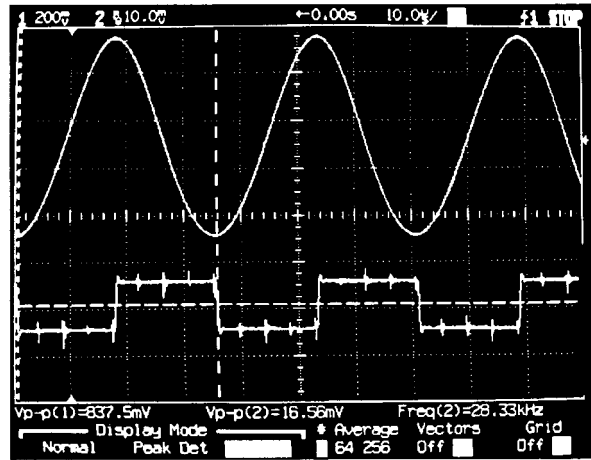


Fig. 14. Square-wave drive signal generated by the lock-in amplifier and the output signal from the gyroscope.

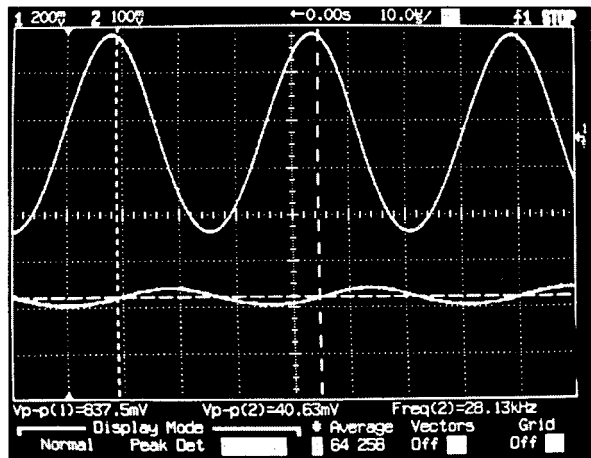


Fig. 15. ZRO of the gyroscope (bottom trace) after balancing. The top trace shows the output of the drive mode.

Once the circuit has locked to the flexural mode, the electronic tuning of the structure will be performed. The third loop, which is called the quadrature control loop, continuously adjusts one pair of balancing voltages located at $\pm 22.5^\circ$ to null out the quadrature signal, or the zero rate output (ZRO), which is in phase quadrature with the Coriolis-induced output signal. Issues related to each of these control loops have been discussed in details in [10]. For closed-loop operation of the sensor, an extra loop has to be used to force the output displacement to zero. Fig. 15 shows the zero rate output of a prototype ring gyroscope after balancing. The bottom trace is the 45° sense signal and the top trace is the 0° sense signal and the device was drive at 0° drive. The quadrature phase difference can be verified in this picture.

The response of a prototype polysilicon ring gyroscope to input rotation rates up to ± 250 deg/s was measured in a bandwidth of 5 Hz. Fig. 16 shows the response of the device to a 5 Hz sinusoidal input rotation rate with a peak-to-peak amplitude of 120 deg/s. It should be noted that this measurement was carried out under very poor vacuum level and the quality factor was only about 250 which is an order of magnitude less than the actual Q of the ring structure under high vacuum. This drop

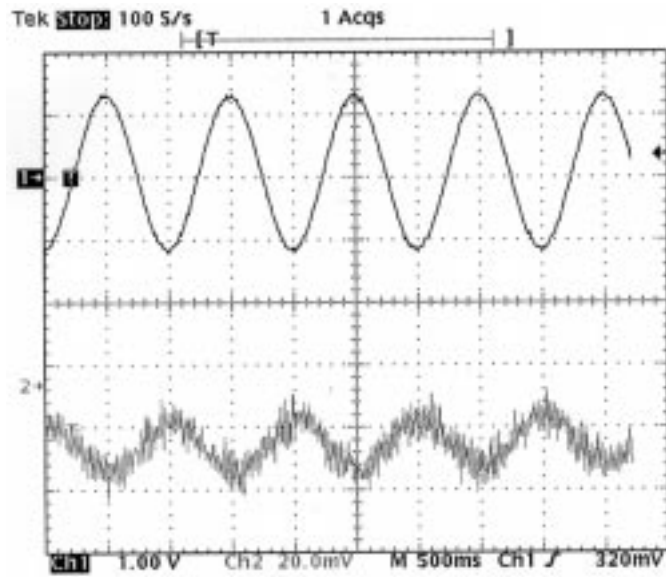


Fig. 16. Response of a prototype single ring gyroscope (lower trace) to a 5-Hz sinusoidal rate with a peak-to-peak amplitude of 120 deg/s.

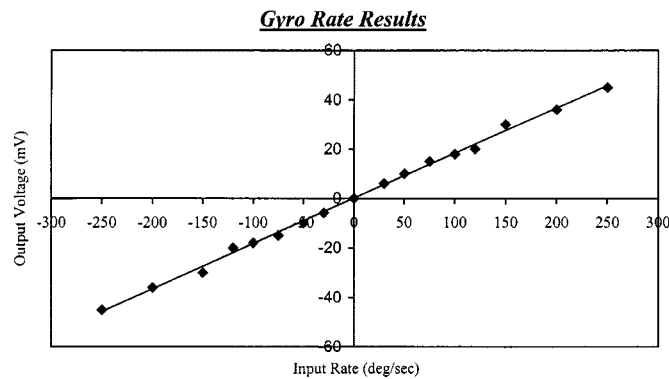


Fig. 17. Response of a prototype PRG to input rotation rates in a 5 Hz BW. The sensitivity of this device under poor vacuum ($Q \approx 250$) was around $200 \mu\text{V}/\text{deg/s}$.

in the quality factor reduces the open loop output signal by a factor of 10. Also, the output signal has been further reduced due to large amount of parasitic capacitance in the output sense node. The rest capacitance associated with each electrode in a single ring design has been measured to be around 500 fF, which agrees with calculated value. However, the input capacitance of the buffer chip along with the capacitance associated with the bonding pad on the IC chip and, the parasitic capacitance of the long wire-bonds used for hybrid connection have been measured to be around 1.5 pF total. Therefore the total amount of the rest capacitance associated with each sense pad was around 2 pF! This large capacitance has degraded the output signal by an additional factor of 4. Elimination of these two factors will increase the output signal by a factor of 40.

Fig. 17 is the response of the sensor to input rotation rates in 5 Hz bandwidth. The sensitivity under very poor vacuum ($Q \approx 250$) and large parasitics (2 pF) was measured to be $200 \mu\text{V}/\text{deg/s}$. Another set of measurements was taken under im-

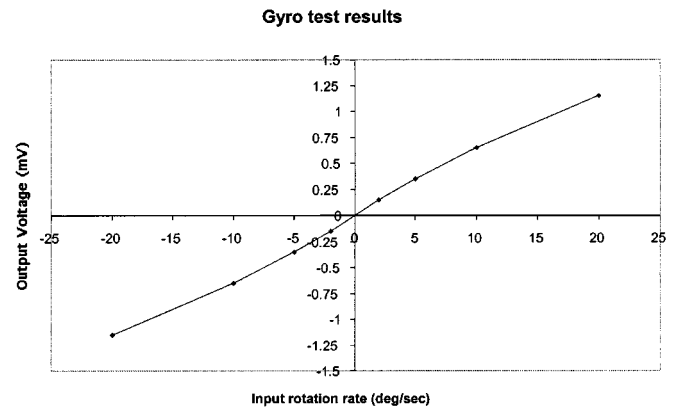


Fig. 18. Measured rate results obtained from a prototype PRG in a 5-Hz BW, range = $\pm 20^\circ/\text{s}$ ($Q \approx 1200$).

proved vacuum levels. The Q of the device was measured to be approximately 1200 after balancing. Fig. 18 shows the response of the sensor to rotation rates in the range of -20 deg/s to 20 deg/s . The resolution of the sensor was measured to be $\sim 1 \text{ deg/s}$ in 1 Hz bandwidth. This resolution for a Q of 1200 and parasitic capacitances of 2 pF is in agreement with the theory. The resolution of the sensor is currently limited by the noise from the circuitry. Elimination of parasitic capacitances and improvement in Q will reduce the resolution to 0.01 deg/s in 1 Hz bandwidth, which is the Brownian noise floor for the current design of the polysilicon ring gyroscope with a drive amplitude of $0.15 \mu\text{m}$.

VI. CONCLUSION

This paper presents the design, fabrication and testing of a high aspect-ratio $80 \mu\text{m}$ thick, 1.1 mm in diameter polysilicon ring gyroscope fabricated using the HARPSS process. The single-crystal silicon electrodes were $60 \mu\text{m}$ tall and the capacitive gaps were $1.4 \mu\text{m}$. An open-loop sensitivity of $200 \mu\text{V}/\text{deg/s}$ in a dynamic range of $\pm 250 \text{ deg/s}$ was measured under low vacuum level for a prototype device tested in hybrid format. The resolution for a prototype sensor with a quality factor (Q) of 1200, drive amplitude of $0.15 \mu\text{m}$, and sense-node parasitic capacitance of 2 pF was measured to be less than 1 deg/s in 1 Hz bandwidth. Elimination of the parasitic capacitance and improvement in the quality factor of the ring structure will improve the resolution to $0.01 \text{ deg/s}/(\text{Hz})^{0.5}$.

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